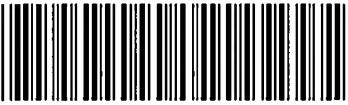


Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/552,588		OTSUBO ET AL.	
				Examiner		Art Unit	
				Diem Tran		3748	

ISSUE CLASSIFICATION

ORIGINAL			CROSS REFERENCE(S)				
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
60	295	60	286	297	311		
INTERNATIONAL CLASSIFICATION							
F	0	1	N	3/00			
				/			
				/			
				/			
				/			

Reen Tran 11/9/06
(Assistant Examiner) (Date)

Dawn Brewer 11/13/06
(Legal Instruments Examiner) (Date)

THOMAS DENION
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 3700
(Primary Examiner) *Thomas Denion* (Date) 11/13/06

Total Claims Allowed: 7

O.G. Print Claim(s) 1	O.G. Print Fig. 1
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<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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5		35	65	95	125	155	185
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7		37	67	97	127	157	187
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